

120V, 145A, 3.2mΩ N-channel Power SGT MOSFET

JMSH1204PC

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

- Load Switch
- PWM Application
- Power Management

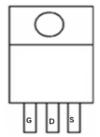
Product Summary

Parameters	Value	Unit
V_{DSS}	120	V
$V_{GS(th)_Typ}$	2.9	V
$I_D(@V_{GS}=10V)$	145	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	3.2	mΩ

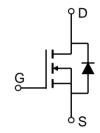








Pin Assignment



Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel&Tube(pcs)	Per Carton (pcs)
JMSH1204PC	JMSH1204PC	N/A	Tube	TO-220-3L	50	5000

Absolute Maximum Ratings (@ $T_C = 25$ °C unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage		120	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	$T_C = 25^{\circ}C$	145	^
I _D	Continuous Diain Current	$T_C = 100$ °C	103	- A
I _{DM}	Pulsed Drain Current (1)	-	Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energy	y ⁽²⁾	1061	mJ
P_{D}	Payer Dissipation	$T_C = 25$ °C	208	W
' D	Power Dissipation	$T_C = 100$ °C	83	¬
T_{J} , T_{STG}	Junction & Storage Temperature R	lange	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	32	°C/M	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.6	°C/W	



Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					l
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	120	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 96V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics				•	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0	2.9	3.7	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	3.2	4.1	mΩ
Dynami	c Characteristics					
R_g	Gate Resistance	f = 1MHz	-	3.1	-	Ω
C_{iss}	Input Capacitance	., ., ., ., .,	4834	6768	9137	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 60V$, $f = 1MHz$	542	759	1024	pF
C_{rss}	Reverse Transfer Capacitance]	17	24	33	pF
Q_g	Total Gate Charge	V 0 40V	74	104	140	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 60V, I_{D} = 20A$	26	36	49	nC
Q_gd	Gate Drain("Miller") Charge	_ V _{DS} = 00 V, I _D = 2070	18	25	34	nC
Cwitchi	ng Characteristics					
t _{d(on)}	Turn-On DelayTime	Τ		33	Ι -	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 60V$	_	61	_	ns
t _{d(off)}	Turn-Off DelayTime	I_{D} = 20A, R_{GEN} = 6.2 Ω	_	92	_	ns
t _f	Turn-Off Fall Time	1	-	59	-	ns
Body D	iode Characteristics					
I _S	Maximum Continuous Body Diode Forward	Current	-	-	145	А
I _{SM}	Maximum Pulsed Body Diode Forward Curi	ent	-	-	581	Α
V _{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	1 - 204 di/dt - 1004/::2	80	112	151	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$, di/dt = 100A/us	-	450	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

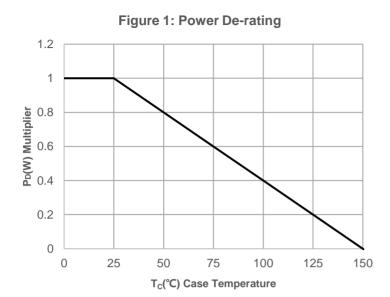
 $^{2.\;}E_{AS}\;condition:\;Starting\;T_{J}=25C,\;V_{DD}=60V,\;V_{G}=10V,\;R_{G}=25ohm,\;L=3mH,\;I_{AS}=26.6A,\;V_{DD}=0V\;during\;time\;in\;avalanche.$

^{3.} $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

^{4.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



Typical Performance Characteristics



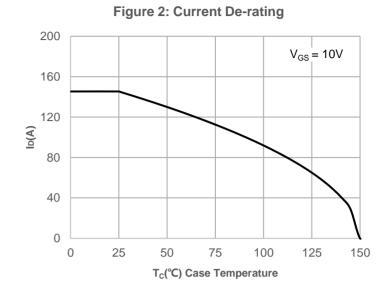
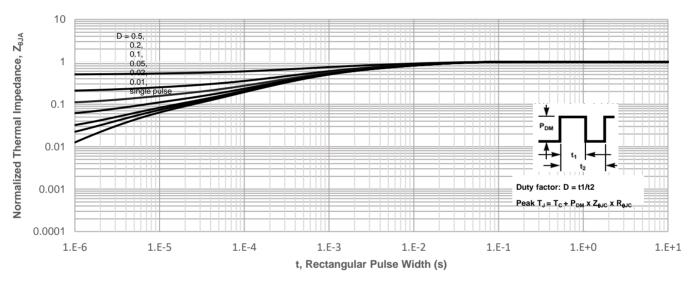
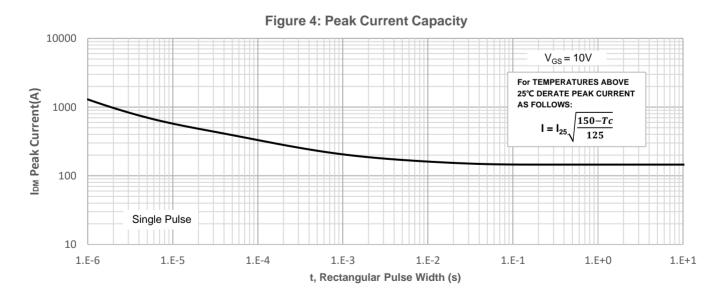


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

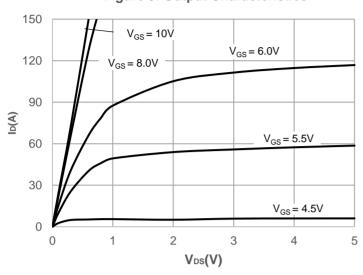


Figure 6: Typical Transfer Characteristics

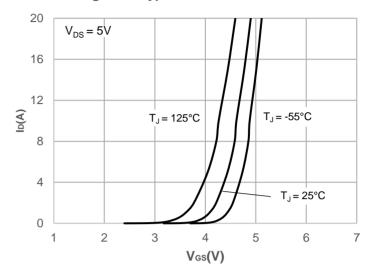


Figure 7: On-resistance vs. Drain Current

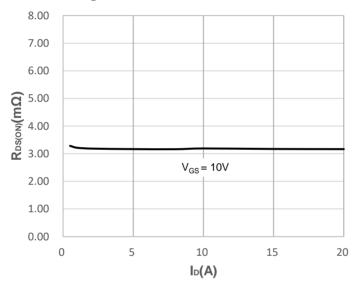


Figure 8: Body Diode Characteristics

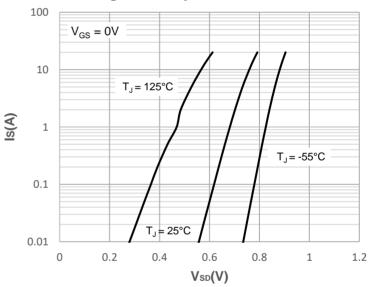


Figure 9: Gate Charge Characteristics

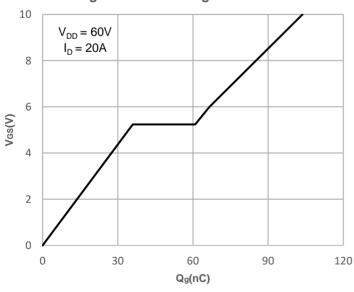
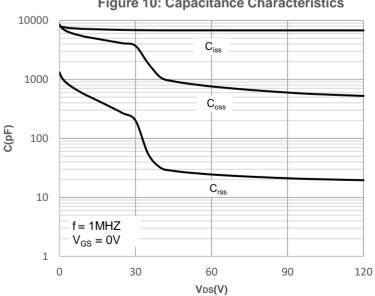


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

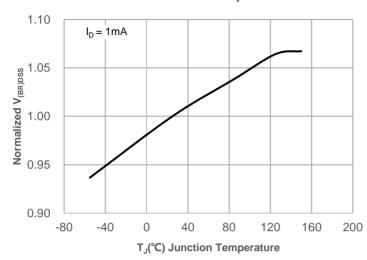


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

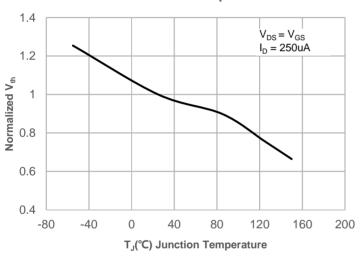


Figure 15: Maximum Safe Operating Area

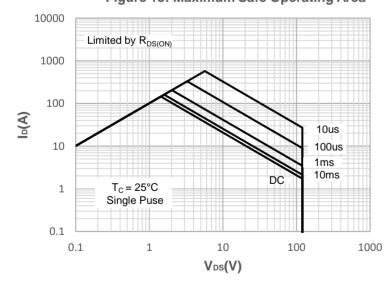
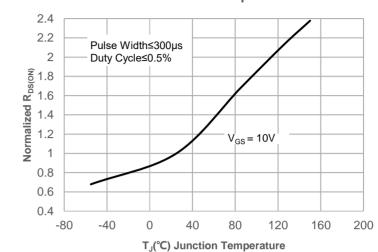
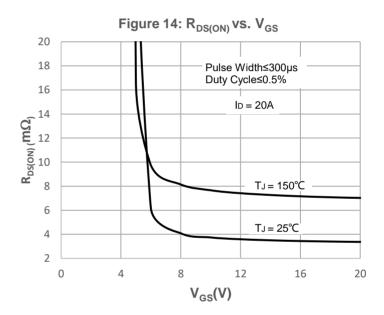


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

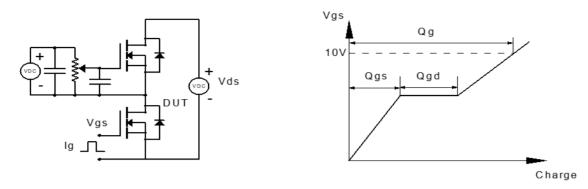


Figure 1: Gate Charge Test Circuit & Waveform

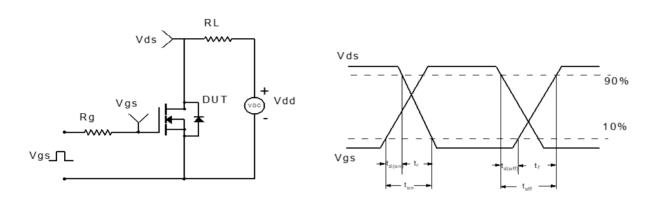


Figure 2: Resistive Switching Test Circuit & Waveform

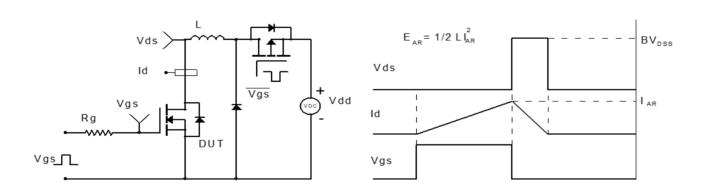


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

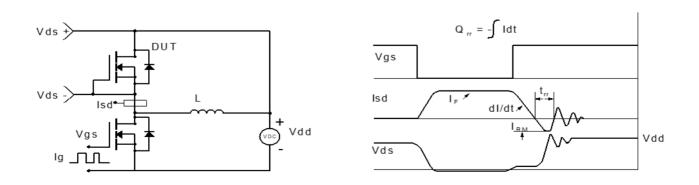
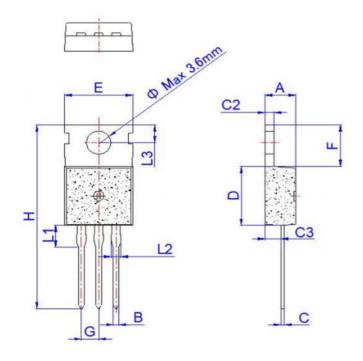


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-220-3L)



Ref.	Dimensions						
	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	4.40		4.60	0.173		0.181	
В	0.70		0.90	0.028		0.035	
С	0.45		0.60	0.018		0.024	
C2	1.23		1.32	0.048		0.052	
C3	2.20		2.60	0.087		0.102	
D	8.90		9.90	0.350		0.390	
E	9.90		10.3	0.390		0.406	
F	6.30		6.90	0.248		0.272	
G		2.54			0.1		
Н	28.0		29.8	1.102		1.173	
L1		3.39			0.133		
L2	1.14		1.70	0.045		0.067	
L3	2.65		2.95	0.104		0.116	
Φ		3.6			0.142		

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